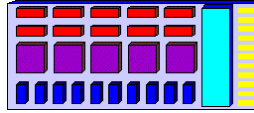


Standard Reliability Prediction Report

Part Number BAT104-NiCd
Reference Des
Date June 11, 2004
Environment GB, GC - Ground Benign, Controlled
Temperature 30.00

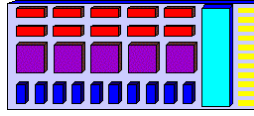


Description Top-level assembly
File Name BAT104-NiCd.RPJ
Time 12:13 PM
Failure Rate 0.941105
MTBF 1,062,581

Assembly Name	Part Number	Ref Des	Qty	Failure Rate	MTBF
BAT104-NiCd	BAT104-NiCd		1.00	0.941105	1,062,581
SANYO N-600-AAK	>500 CYCLES				

Standard Reliability Prediction Report

Part Number BAT104-NiCd
Reference Des
Date June 11, 2004
Environment GB, GC - Ground Benign, Controlled
Temperature 30.00



Description Top-level assembly
File Name BAT104-NiCd.RPJ
Time 12:13 PM
Failure Rate 0.941105
MTBF 1,062,581

Part Number	Category	Ref Des	Failure Rate, Unit	Quantity	Failure Rate
CON-PC104-16PF	Connection		0.052000	2.00	0.104000
CON-PC104-8PF	Connection		0.083200	1.00	0.083200
CON-SOC-0.1-2X4	Connection		0.010400	1.00	0.010400
FET-DPAK-N	Semiconductor		0.186219	1.00	0.186219
FET-SOT23-P	Semiconductor		0.438329	1.00	0.438329
FUSE-AXIAL-7A-SB	Miscellaneous		0.010000	1.00	0.010000
FUSE-TCO-84C	Miscellaneous		0.010000	1.00	0.010000
IC-LM75CIM5	Integrated Circuit		0.032442	1.00	0.032442
PCB-BAT104-NICADV2	Connection		0.034000	1.00	0.034000
RES-0805-100K	Resistor		0.016257	2.00	0.032514